

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/716,749	KIM ET AL.
	Examiner TRONG PHAN	Art Unit 2827

Search Notes



Application/Control No.

10/716,749

Examiner

TRONG PHAN

**Applicant(s)/Patent under
Reexamination**

KIM ET AL.

Art Unit

2827

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